## N－Channel 60 V（D－S）MOSFET

| PRODUCT SUMMARY |  |  |  |
| :---: | :---: | :---: | :---: |
| $\mathbf{V}_{\mathbf{D S}}(\mathbf{V})$ | $\mathbf{R}_{\mathrm{DS}(\mathrm{on})}(\Omega)$ | $\mathbf{I}_{\mathbf{D}}(\mathbf{A})^{\mathbf{a}, \mathbf{e}}$ | $\mathbf{Q}_{\mathbf{g}}(\mathbf{M a x})$ |
| 60 | 0.023 at $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ | 50 | 66 nC |
|  | 0.027 at $\mathrm{V}_{\mathrm{GS}}=4.5 \mathrm{~V}$ | 40 |  |

## FEATURES

－Halogen－free According to IEC 61249－2－21 Definition
－Surface Mount
－Available in Tape and Reel
－Dynamic dV／dt Rating
－Logic－Level Gate Drive
－Fast Switching
－Compliant to RoHS Directive 2002／95／EC


RoHS＊
COMPLANT
halogen FREE Available



N－Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $\left(\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}\right.$ ，unless otherwise noted）

| PARAMETER |  |  | SYMBOL | LIMIT | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Drain－Source Voltage |  |  | $\mathrm{V}_{\text {DS }}$ | 60 | V |
| Gate－Source Voltage |  |  | $\mathrm{V}_{\mathrm{GS}}$ | $\pm 10$ |  |
| Continuous Drain Current ${ }^{\dagger}$ | $\mathrm{V}_{\mathrm{GS}}$ at 10 V | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | ID | 50 | A |
| Continuous Drain Current |  | $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ |  | 36 |  |
| Pulsed Drain Current ${ }^{\text {a }}$ |  |  | IDM | 200 |  |
| Linear Derating Factor |  |  |  | 1.0 | W／${ }^{\circ} \mathrm{C}$ |
|  |  |  |  | 0.025 |  |
| Single Pulse Avalanche Energy ${ }^{\text {b }}$ |  |  | $\mathrm{E}_{\text {AS }}$ | 400 | mJ |
| Maximum Power Dissipation | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ |  | $\mathrm{P}_{\mathrm{D}}$ | 150 | W |
| Maximum Power Dissipation（PCB Mount）${ }^{\text {e }}$ | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ |  |  | 3.7 |  |
| Peak Diode Recovery dV／dtc |  |  | dV／dt | 4.5 | V／ns |
| Operating Junction and Storage Temperature Range |  |  | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | -55 to＋175 | C |
| Soldering Recommendations（Peak Temperature）${ }^{\text {d }}$ |  |  |  | $300{ }^{\text {d }}$ |  |

## Notes

a．Repetitive rating；pulse width limited by maximum junction temperature（see fig．11）．
b．$V_{D D}=25 \mathrm{~V}$ ，starting $\mathrm{T}_{J}=25^{\circ} \mathrm{C}, \mathrm{L}=179 \mu \mathrm{H}, \mathrm{R}_{\mathrm{g}}=25 \Omega, \mathrm{I}_{\mathrm{AS}}=51 \mathrm{~A}$（see fig．12）．
c．$I_{S D} \leq 51 \mathrm{~A}, \mathrm{dl} / \mathrm{dt} \leq 250 \mathrm{~A} / \mu \mathrm{s}, \mathrm{V}_{\mathrm{DD}} \leq \mathrm{V}_{\mathrm{DS}}, \mathrm{T}_{\mathrm{J}} \leq 175^{\circ} \mathrm{C}$ ．
d． 1.6 mm from case．
e．When mounted on 1 ＂square PCB（FR－4 or G－10 material）．
f．Current limited by the package，$($ die current $=51 \mathrm{~A})$ ．

| THERMAL RESISTANCE RATINGS |  |  |  |  |
| :--- | :---: | :---: | :---: | :---: |
| PARAMETER | SYMBOL | TYP． | MAX． | UNIT |
| Maximum Junction－to－Ambient | $\mathrm{R}_{\mathrm{thJA}}$ | - | 62 |  |
| Maximum Junction－to－Ambient <br> （PCB Mount）$^{\mathrm{a}}$ | $\mathrm{R}_{\mathrm{thJA}}$ | - | 40 |  |
| Maximum Junction－to－Case（Drain） | $\mathrm{R}_{\mathrm{thJC}}$ | - | 1.0 |  |

## Note

a．When mounted on $1^{\prime \prime}$ square PCB（FR－4 or G－10 material）．

| SPECIFICATIONS（ $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ ，unless otherwise noted） |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| PARAMETER | SYMBOL | TEST CONDITIONS |  | MIN． | TYP． | MAX． | UNIT |
| Static |  |  |  |  |  |  |  |
| Drain－Source Breakdown Voltage | $\mathrm{V}_{\mathrm{DS}}$ | $\mathrm{V}_{\mathrm{GS}}=0, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ |  | 60 | － | － | V |
| $V_{\text {DS }}$ Temperature Coefficient | $\Delta \mathrm{V}_{\mathrm{DS}} / \mathrm{T}_{\mathrm{J}}$ | Reference to $25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{D}}=1 \mathrm{~mA}$ |  | － | 0.070 | － | V／${ }^{\circ} \mathrm{C}$ |
| Gate－Source Threshold Voltage | $\mathrm{V}_{\mathrm{GS}(\text {（th）}}$ | $V_{\text {DS }}=V_{G S}, I_{D}=250 \mu \mathrm{~A}$ |  | 1.0 | － | 3.0 | V |
| Gate－Source Leakage | $\mathrm{I}_{\text {GSS }}$ | $\mathrm{V}_{\mathrm{GS}}= \pm 10 \mathrm{~V}$ |  | － | － | $\pm 100$ | nA |
| Zero Gate Voltage Drain Current | Idss | $\mathrm{V}_{\mathrm{DS}}=60 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}$ |  | － | － | 25 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{DS}}=48 \mathrm{~V}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{J}}=150^{\circ} \mathrm{C}$ |  | － | － | 250 |  |
| Drain－Source On－State Resistance | $\mathrm{R}_{\mathrm{DS} \text {（on）}}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ |  | － | 23 | － | $\Omega$ |
|  |  | $\mathrm{V}_{\mathrm{GS}}=4.5 \mathrm{~V}$ |  | － | 27 | － |  |
| Forward Transconductance | $\mathrm{g}_{\mathrm{fs}}$ | $\mathrm{V}_{\mathrm{DS}}=25 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=21 \mathrm{~A}^{\mathrm{b}}$ |  | 23 | － | － | S |
| Dynamic |  |  |  |  |  |  |  |
| Input Capacitance | $\mathrm{C}_{\text {iss }}$ | $\begin{gathered} V_{G S}=0 \mathrm{~V}, \\ V_{D S}=25 \mathrm{~V}, \\ \mathrm{f}=1.0 \mathrm{MHz}, \text { see fig. } 5 \end{gathered}$ |  | － | 3000 | － | pF |
| Output Capacitance | $\mathrm{Coss}^{\text {a }}$ |  |  | － | 1000 | － |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {rss }}$ |  |  | － | 200 | － |  |
| Total Gate Charge | $\mathrm{Q}_{\mathrm{g}}$ | $\mathrm{V}_{\mathrm{GS}}=5.0 \mathrm{~V}$ | $\begin{aligned} & \mathrm{I}_{\mathrm{D}}=51 \mathrm{~A}, \mathrm{~V}_{\mathrm{DS}}=48 \mathrm{~V}, \\ & \text { see fig. } 6 \text { and } 13^{\mathrm{b}} \end{aligned}$ | － | 60 | － | nC |
| Gate－Source Charge | $\mathrm{Q}_{\mathrm{gs}}$ |  |  | － | 10 | － |  |
| Gate－Drain Charge | $\mathrm{Q}_{\mathrm{gd}}$ |  |  | － | 40 | － |  |
| Turn－On Delay Time | $\mathrm{t}_{\mathrm{d}(\mathrm{on})}$ | $\begin{gathered} V_{D D}=30 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=51 \mathrm{~A}, \\ \mathrm{R}_{\mathrm{g}}=4.6 \Omega, \mathrm{R}_{\mathrm{D}}=0.56 \Omega \text {, see fig. } 10^{\mathrm{b}} \end{gathered}$ |  | － | 17 | － | ns |
| Rise Time | $\mathrm{t}_{\mathrm{r}}$ |  |  | － | 230 | － |  |
| Turn－Off Delay Time | $\mathrm{t}_{\mathrm{d}(\text { fff })}$ |  |  | － | 42 | － |  |
| Fall Time | $\mathrm{t}_{\mathrm{f}}$ |  |  | － | 110 | － |  |
| Internal Drain Inductance | $L_{D}$ | Between lead， 6 mm （0．25＂）from package and center of die contact |  | － | 4.5 | － | nH |
| Internal Source Inductance | $\mathrm{L}_{\text {s }}$ |  |  | － | 7.5 | － |  |
| Drain－Source Body Diode Characteristics |  |  |  |  |  |  |  |
| Continuous Source－Drain Diode Current | Is | MOSFET symbol showing the integral reverse $\mathrm{p}-\mathrm{n}$ junction diode |  | － | － | $50^{\circ}$ | A |
| Pulsed Diode Forward Current ${ }^{\text {a }}$ | $\mathrm{I}_{\text {SM }}$ |  |  | － | － | 200 |  |
| Body Diode Voltage | $\mathrm{V}_{\text {SD }}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{S}}=51 \mathrm{~A}, \mathrm{~V}_{\mathrm{GS}}=0 \mathrm{~V}^{\mathrm{b}}$ |  | － | － | 2.5 | V |
| Body Diode Reverse Recovery Time | $\mathrm{t}_{\mathrm{rr}}$ | $\mathrm{T}_{J}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{F}}=51 \mathrm{~A}, \mathrm{dl} / \mathrm{dt}=100 \mathrm{~A} / \mu \mathrm{s}^{\mathrm{b}}$ |  | － | 130 | 180 | ns |
| Body Diode Reverse Recovery Charge | $\mathrm{Q}_{\mathrm{rr}}$ |  |  | － | 0.84 | 1.3 | $\mu \mathrm{C}$ |
| Forward Turn－On Time | $\mathrm{t}_{\text {on }}$ | Intrinsic turn－on time is negligible（turn－on is dominated by $L_{S}$ and $L_{D}$ ） |  |  |  |  |  |

## Notes

a．Repetitive rating；pulse width limited by maximum junction temperature（see fig．11）．
b．Pulse width $\leq 300 \mu \mathrm{~s}$ ；duty cycle $\leq 2 \%$ ．
c．Current limited by the package，（Die Current $=51$ A）．

TYPICAL CHARACTERISTICS $\left(25^{\circ} \mathrm{C}\right.$ ，unless otherwise noted）


Fig． 1 －Typical Output Characteristics， $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$


Fig． 2 －Typical Output Characteristics， $\mathrm{T}_{\mathrm{C}}=150^{\circ} \mathrm{C}$


Fig． 3 －Typical Transfer Characteristics


Fig． 4 －Normalized On－Resistance vs．Temperature


Fig． 5 －Typical Capacitance vs．Drain－to－Source Voltage


Fig． 6 －Typical Gate Charge vs．Gate－to－Source Voltage


Fig． 7 －Typical Source－Drain Diode Forward Voltage


Fig． 8 －Maximum Safe Operating Area


Fig． 9 －Maximum Drain Current vs．Case Temperature


Fig．10a－Switching Time Test Circuit


Fig．10b－Switching Time Waveforms


Fig． 11 －Maximum Effective Transient Thermal Impedance，Junction－to－Case


Fig．12a－Unclamped Inductive Test Circuit


Fig．12b－Unclamped Inductive Waveforms


Fig．12c－Maximum Avalanche Energy vs．Drain Current


Fig．13a－Basic Gate Charge Waveform


Fig．13b－Gate Charge Test Circuit

## Peak Diode Recovery dV／dt Test Circuit



Note
a． $\mathrm{V}_{\mathrm{GS}}=5 \mathrm{~V}$ for logic level devices
Fig． 14 －For N－Channel

## RECOMMENDED MINIMUM PADS FOR D²PAK：3－Lead



Recommended Minimum Pads
Dimensions in Inches／（mm）

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